Probing the local distortion of Fe sites in Fe₃O₄ thin films using enhanced symmetry selection in XMLD

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Magnetite (Fe₃O₄) thin-films are among the most stimulating systems for electronic applications, in particular given that their electric and magnetic properties can be controlled by substrate strain. Here we investigate the electronic structure of a 38 nm Fe₃O₄/SrTiO₃ (001) thin-film by a unique set of x-ray magnetic linear dichroism (XMLD) measurements. We show that it is only possible to uncover the orbital character of the Fe sites in Fe₃O₄ by a systematic analysis of the XMLD angular distribution. The local symmetry of the Fe²⁺ B site in the thin-film is found to be trigonally distorted. Our results highlight that the combination of state-of-the-art XMLD measurements and theoretical simulations is indispensable for investigating the electronic structure of oxide thin-films and heterostructures.

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I. INTRODUCTION

Oxide heterostructures provide a fruitful playground to generate tuneable properties that can be engineered for electronic, spintronic, multiferroic, and magnetic devices [1–5]. One of the most intriguing oxide systems is magnetite (Fe₃O₄), which in the form of thin-films, is ideal for spintronic applications because of its half metallicity and strong spin polarization at the Fermi level [6-8]. Moreover, Fe₃O₄ exhibits a metal to insulator transition, the Verwey transition, at $T_V \sim 125 \,\mathrm{K}$ which results in a spontaneous change of both the lattice symmetry and the electric conductivity [9,10]. Verwey proposed that at T_V a charge ordering transition takes place [10] which gave rise to considerable efforts devoted to finding evidence for the proposed charge ordering [11-14]. This drastic change in conductivity was also found to occur on the picosecond timescale [15,16], opening novel avenues for designing fast electronics.

Above T_V , Fe₃O₄ has a cubic inverse spinel crystal structure (space group $Fd\bar{3}m$, $a_{Bulk} = 8.3965$ Å [17]) containing two different Fe sites. Figure 1 illustrates how the Fe₃O₄ inverse spinel crystal structure consists of Fe³⁺ ions in tetrahedral coordination (A sites), and Fe²⁺ and Fe³⁺ ions (or, on average, Fe^{2.5+}) in nearly octahedral coordination (B sites formally belonging to the $\bar{3}m$ point group) with O²⁻ ions in a FCC lattice [17]. The Fe A and B sublattices are antiferromagnetically coupled while the Fe ions at the B sublattice

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are ferromagnetically coupled (Fig. 1) leading to a Curie temperature of $T_C \sim 860$ K.

High quality single crystal thin-films of Fe₃O₄ can be epitaxially grown, interfaced, and integrated on different substrates such as MgO (a = 4.212 Å), SrTiO₃ (a = 3.905 Å), and MgAl₂O₄ (a = 8.0831 Å) [18–23] providing an appropriate architecture for technological device integration. The resulting electronic and magnetic properties of the thin-films are governed by growth characteristics such as strain, stoichiometry, and defect states [20–26]. It is in fact a highly nontrivial task to predict the resulting properties given the closely competing energy scales (such as distortion, exchange, Kugel-Khomskii, and spin-orbit coupling) which cause the properties to be strongly dependent on small changes in the atomic structure. For example, recent studies showed that it is possible to modify the Verwey transition temperature of Fe₃O₄ by tuning the lattice mismatch by 0.66% [20,26].

Although the use of strain energy imposed by epitaxial growth is one of the primary routes to engineering the properties of Fe_3O_4 thin-films, its effect on the electronic structure remains controversial. As the Verwey transition is associated with charge and orbital ordering, being able to control it with strain requires a detailed microscopic understanding of the local Fe electronic and magnetic structure. It is therefore desirable to sensitively probe the charge, spin, and orbital degrees of freedom of the Fe ions in Fe_3O_4 to determine the effect of strain on the local site symmetry. This remains a task beyond standard techniques such as diffraction and scanning transmission electron microscopy (STEM) because the oxygen positions are not easily determined.

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FIG. 1. Schematics of the inverse spinel Fe_3O_4 cubic unit cell, where Fe^{3+} cations (green) occupy tetrahedral A sites while both Fe^{2+} and Fe^{3+} cations (blue) occupy nearly octahedral B sites. The B (red arrow) and A sites (magenta arrow) are antiferromagnetically coupled.

In this work, we use XMLD measurements at the Fe $L_{2,3}$ edge of Fe₃O₄ (38 nm, $a_{\text{Film}} = 8.36$ Å as detailed in Fig. S2) grown on an SrTiO₃ (001) substrate to study the electronic and magnetic structure of the Fe sites in the thin-film. The large lattice mismatch between SrTiO₃ and Fe₃O₄ (~7.5% [27]) makes it an interesting heterostructure to investigate, in particular, given that SrTiO₃ is a backbone electrode material for oxide electronics. The thickness of the film lies in between the critical thickness, $t_{\text{crit}} = 7$ nm and $10t_{\text{crit}}$ where structural relaxation and reconstructions are predicted to occur [21,24]. Such distortion can have dramatic effects by modifying orbital degeneracies, and in turn orbital ordering patterns.

We demonstrate here that it is possible to unambiguously determine the symmetry of Fe ions in Fe₃O₄ through a systematic analysis of the angular-dependent XMLD signal. Furthermore, we show that the small Jahn-Teller distortions can be best determined when the XMLD signal is measured in an optimized configuration. Our measurements combined with theoretical simulations reveal that the nominal Fe²⁺ B sites of the Fe₃O₄/SrTiO₃ thin-film are trigonally distorted. The distortion parameter concluded is consistent in sign and close in magnitude to that of bulk Fe₃O₄. The methodology developed here provides a blueprint for the characterization of thin-films where the interplay between various interactions, such as magnetic exchange, spin-orbit coupling, and the Jahn-Teller distortion, all play a role in determining the low energy state.

II. METHODOLOGY

A. Experimental details

The Fe₃O₄ thin-film was grown on a conductive 0.1% Nb-doped SrTiO₃ (001) TiO₂-terminated substrate by pulsed laser deposition (PLD) as described by Hamed *et al.* [19]. Briefly, the substrate temperature and oxygen partial pressure were kept at 400° C and 2×10^{-6} mbar, respectively. We used a laser fluence of 1.5 J/cm^2 with a repetition rate of 5 Hz producing ionized particles from a Fe₂O₃ (purity 99.9%) rotating target. In this setup, the substrate was mounted 50 mm away from the target.

The film thickness, interface, and surface roughness were examined by x-ray reflectivity (XRR) with Cu K_{α} -radiation

as shown in Fig. S1 [28]. The epitaxial growth condition was checked using XRD measurements reported in Fig. S2. Bulk magnetic properties were investigated by a vibrating sample magnetometer using a quantum design dynacool physical properties measurement system. The magnetic moment versus temperature, M(T), was measured in zero field cooling (ZFC) mode with 500 Oe applied field to determine the Verwey transition as shown in Fig. S3. Hysteresis loops were recorded with a magnetic field, $B = \pm 5$ T, applied parallel to the inplane [100] direction (see Fig. S4).

X-ray magnetic circular dichroism (XMCD) and XMLD measurements were carried out on beamline I06 of Diamond Light Source, UK. The beam spot at the sample position is estimated to be $\sim 200 \,\mu m \times 100 \,\mu m$. A vector magnet set to B = 1 T was used to saturate the magnetization to any arbitrary direction. All measurements were performed at T = 200 K in a normal incidence configuration, i.e., with the incoming beam impinging at an angle of 90° with respect to the sample surface. The energy resolution is estimated to be $\sim 200 \text{ meV}$ full width half maximum (FWHM). The measurements were performed in total electron yield (TEY) and fluorescence yield (FY) mode.

All experimental spectra were first normalized to the incident photon flux. The spectra were then fitted using a model consisting of two error functions to take into account the $L_{2,3}$ edge jumps. In addition, a set of Gaussian functions were used to fit the multiplet features of the spectra (refer to the Supplementary Information for more details [28]). The $L_{2,3}$ edge jumps were subtracted from the spectra and the spectra were renormalized to the spectral area.

B. Theoretical simulations

Crystal field multiplet calculations were performed using the quantum many-body program QUANTY [29–31]. Three independent Fe sites were considered for the calculations, namely, Fe²⁺ in octahedral symmetry (O_h), Fe³⁺ in octahedral symmetry (O_h), and Fe³⁺ in tetrahedral symmetry (T_d). The Hamiltonian used for the calculations involved the following terms: (i) Coulomb interaction, (ii) crystal field potential, (iii) spin-orbit coupling, and (iv) magnetic exchange interaction as detailed in [32]. The optimized parameters used for the calculations are reported in Tables S4, S5, and S6 of the Supplementary Material [28]. Two sets of calculations were performed.

(1) Calculations for strained Fe₃O₄ thin-film where the effects of substrate bi-axially induced distortion were simulated by reducing the nominal point group symmetry of Fe²⁺ ions to tetragonal symmetry (D_{4h}).

(2) Calculations for a relaxed Fe₃O₄ thin-film where four trigonally distorted (D_{3d}) Fe²⁺O₆ clusters were taken into consideration to simulate bulk-like Fe₃O₄ (see Supplementary Information for more details [28]).

The choice of the magnitude of the distortion parameters were based on the effect on the XMLD features (see Figs. S10 and S11 for more details). We note that we investigated the effect of distortion only at the nominal Fe^{2+} ion because the ${}^{5}D_{4}$ ground state of the Fe^{2+} ion is strongly influenced by distortion while the ${}^{6}A_{1}$ ground state of the Fe^{3+} ions does not split by distortion to a first



FIG. 2. Fe $L_{2,3}$ XAS and XMCD spectra from Fe₃O₄ measured in TEY mode. (a) Experimental XAS and XMCD spectra of a Fe₃O₄ thin-film. The positions of the main peaks observed for XAS and XMCD are shown by the vertical ticks. Multiplet calculations of the XMCD signal are shown in (b), (c), and (d) for three distortion types at the Fe²⁺ B sites, namely, octahedral (O_h), tetragonal (D_{4h} , $D_s = 0.1$ eV), and trigonal (D_{3d} , $D_{\sigma} = 0.1$ eV). The individual contributions of the Fe ions to the XMCD signal is shown in (e). A sketch of the experimental geometry is shown at the top of the figure.

approximation. A comparison between calculations of the Fe^{3+} XMLD spectra with and without distortion are presented in Figs. S7 and S8.

III. RESULTS

A. Limitations of XMCD in mixed valence systems

Soft x-ray absorption spectroscopy (XAS) and XMCD techniques have developed into powerful tools to characterize magnetic thin-films [33]. XAS can be used to determine the electronic state of the transition metal [34] while sum rules applied to the XMCD allows the spin and orbital magnetic moments to be determined [35,36]. However, the lifetime broadening of the XAS spectra at $L_{2,3}$ -edges ($\sim 0.2 \text{ eV}$) imposes a challenge to the identification and quantification of small distortions induced in thin-films, particularly given the rich multiplet states [37]. This limitation is even more pronounced for mixed valence systems, such as Fe₃O₄, where the XAS spectra are broader because multiple ions contribute to the signal. Only four peaks can be clearly identified from the L_3 XAS measurements at ~ 706 , 707.5, 709, and 710 eV as shown by the vertical ticks in Fig. 2(a).

The experimental XMCD signal of Fe_3O_4 is shown in Fig. 2(a). The spectral shape is consistent with previously reported measurements [38–42]. A detailed comparison between XMCD measurements of the thin-film and bulk Fe_3O_4 is presented in Fig. S9. Three main peaks are observed at the L_3 region of the XMCD indicated by the vertical ticks, namely at 707.5, 709, and 710 eV. The first and the third peaks have the same sign (positive dichroism) while the second peak exhibits an opposite dichroism. The three peaks are

TABLE I. Computed magnetic spin and orbital moments of Fe²⁺ B sites in three local symmetries, namely, octahedral (O_h) , tetragonal (D_{4h}) , and trigonal (D_{3d}) . The reported errors are obtained from the errors in the distortion parameters $10D_q$, D_s , and D_{σ} , respectively.

Symmetry	Magnetic moment (μ_B)	
	Spin	Orbital
$\overline{O_h}$	-3.9425 ± 0.0002	-0.98 ± 0.03
$D_{4h}, D_s = 0.1 \mathrm{eV}$	-3.958 ± 0.007	-0.25 ± 0.05
$D_{3d}, D_{\sigma} = 0.1 \mathrm{eV}$	-3.983 ± 0.004	-0.22 ± 0.02

associated mainly with the Fe²⁺ B ions (707.5 eV), Fe³⁺ A ions (709 eV), and Fe³⁺ B ions (710 eV) as shown in Fig. 2(e). For this reason, the ferromagnetically coupled Fe B ions have the same sign of XMCD while the antiferromagnetically coupled Fe A ions have an opposite XMCD sign.

To investigate the effect of local distortions on XMCD spectra we computed the theoretical XMCD spectra considering perfectly octahedral (O_h) , tetragonal (D_{4h}) , and trigonal (D_{3d}) distorted ions at the Fe²⁺ B sites. Despite some minor differences between the three simulations [compare the calculations presented in Figs. 2(b)-2(d)], it is not possible to unambiguously determine the local symmetry of the Fe ions from the XMCD signal. This uncertainty regarding the local symmetry obscures the quantification of the ion percentages which is commonly determined using XMCD [43]. We found a nearly 4% difference in the quantification between the three simulations (see Table S7). Moreover, the orbital moments deduced from these simulations using the three local symmetries are significantly different as shown in Table I. This ambiguity then strongly limits the information that can be deduced from such measurements on complex systems.

B. X-ray magnetic linear dichroism

XMLD has recently gained attention in studying the magnetic properties of thin-films and especially for antiferromagnetic systems [44–52]. XMLD can be obtained by the difference in the XAS cross-section measured with linearly polarized light and two perpendicular orientations of the magnetic field or fixed orientation of the field and two perpendicular light polarizations. Details of the possible configurations that can be used to measure XMLD were discussed by Arenholz et al. [50]. It can be used to determine the anisotropic magnetic moments and the anisotropic spin-orbit interaction [53–56]. Such information is valuable for understanding and harnessing the magnetic properties of thin-films and multilayers. However, the analysis of XMLD is far from being straightforward because the signal includes structural (crystal field) and magnetic effects. This implies that XMLD is strongly affected by the relative orientation of the external magnetic field (B), s-ray polarization (ϵ), and the crystalline axes. A systematic XMLD measurement combined with theoretical simulations can shed light on the origin of the signal and reveal many fine details of the electronic and the magnetic structure. We measured the XMLD signal with linear horizontally polarized



FIG. 3. Fe $L_{2,3}$ XMLD spectra from Fe₃O₄ detected in TEY mode. (a) A schematic of the experimental geometry. The linear horizontal polarization (LH) is aligned parallel to [100]. The XMLD signal is computed by subtracting the XAS signal measured with the external magnetic field (**B**) parallel to [100] ($\phi = 0^{\circ}$) from that measured with **B** parallel to [010] ($\phi = 90^{\circ}$). **k**_{in} is the incident wave vector. (b) XAS measurements $I(\phi = 0^{\circ})$ and $I(\phi = 90^{\circ})$. The experimental and theoretical XMLD signal are shown in (c) and (d). The experimental and theoretical XMLD angular dependence over 90° computed as $I(\phi) - I(\phi = 0^{\circ})$ are presented in panels (e) and (f), respectively.

x-rays (LH, i.e., $\epsilon \parallel [100]$) with the external field parallel to the [100] ($\phi = 0^{\circ}$) and parallel to [010] ($\phi = 90^{\circ}$) as described in Fig. 3(a). The experimental XMLD signal exhibits a more complex structure in comparison to the XMCD [compare Figs. 3(c) and 2(a)]. Theoretical simulation of the XMLD for perfectly octahedral Fe B sites is shown in Fig. 3(d). The simulation misses two features at 719 and 722.5 eV indicated by the red arrows in the figure. We measured the XMLD angular dependence from $\phi = 0^{\circ}$ to $\phi = 90^{\circ}$ to ensure that the difference between the experimental data and the simulation is not due to a slight misalignment of the sample. The two features at 719 and 722.5 eV are missing for the full angular range as can be seen in Figs. 3(e) and 3(f).

The discrepancy between the experiment and simulations is linked to the assumption made regarding the local symmetry of the Fe ions. On one hand, the lattice mismatch between the SrTiO₃ substrate and Fe₃O₄ can distort the local symmetry. In this case, an in-plane tetragonal compressive distortion would be expected. On the other hand, the point group symmetry of the Fe B sites of bulk Fe₃O₄ is trigonal and hence if the film is relaxed, a trigonal distortion is expected. We investigated the two possible scenarios by simulating the XMLD expected for tetragonally and trigonally distorted Fe B sites. The theoretical XMLD angular dependence computed for tetragonal and trigonal distortions are presented in Fig. 4. Simulations using the distortion parameters $D_s =$ 0.1 eV [Fig. 4(a)] and $D_{\sigma} = 0.1$ eV [Fig. 4(c)] now reproduce the features at 719 and 722.5 eV. Our simulations thus confirm that in-plane compressive tetragonal distortion and trigonal bulk Fe₃O₄-like distortion are both compatible with the observed dichroism signal. On the other hand, calculations with $D_s = -0.1 \,\text{eV}$ [Fig. 4(b)] and $D_\sigma = -0.1 \,\text{eV}$ [Fig. 4(d)] are incompatible.

C. Optimized XMLD angular dependence

Next, we measured the XMLD angular dependence with the incident polarization rotated 30° with respect to the [100] orientation [see Fig. 5(a)]. This orientation does not coincide with a high symmetry axis and hence is expected to provide insights into the nature of the local distortions. The experimental angular dependence is shown in Fig. 5(b). Although the simulations done with tetragonal [$D_s = 0.1 \text{ eV}$, Fig. 5(c)] and trigonal [$D_\sigma = 0.1 \text{ eV}$, Fig. 5(d)] distortion both reproduce the general spectral shape, the ratio between the features



FIG. 4. Theoretical XMLD angular dependence over 90° computed as $I(\phi) - I(\phi = 0)$ for tetragonal symmetry (D_{4h}) with (a) $D_s = 0.1 \text{ eV}$, (b) $D_s = -0.1 \text{ eV}$. Calculations for trigonal symmetry (D_{3d}) with $D_{\sigma} = 0.1 \text{ eV}$ and $D_{\sigma} = -0.1 \text{ eV}$ are shown in panels (c) and (d). The XMLD at $\phi = 45^{\circ}$ is shown as dashed lines.



FIG. 5. Fe L_3 XMLD angular dependence in Fe₃O₄ measured in TEY mode. (a) A schematic of the experimental geometry. The polarization is aligned 30° from the [100] axis. The XMLD is computed as XAS[ϕ] – XAS[ϕ = 30°]. (b) Experimental XMLD angular dependence. Theoretical simulations for tetragonal (D_s = 0.1 eV) and trigonal (D_{σ} = 0.1 eV) distortions are shown in (c) and (d), respectively.

at 707 and 708 eV is only captured by the trigonal symmetry [black arrows in Fig. 5(b)]. The sign and the magnitude of the distortion is consistent with that of bulk Fe₃O₄ ($D_{\sigma,\text{bulk}} = 0.07 \text{ eV}$). This means that the film has nearly fully relaxed at a thickness of only $\sim 6t_{\text{crit}}$.

A comparison between the XMLD measured with TEY and FY could provide insights into the surface versus "bulk" properties of the thin-film. Experiments detected in TEY are surface sensitive because the electron escape range is limited to few nanometers (~4.5 nm in Fe₃O₄ as reported by Gota *et al.* [57]). On the other hand, the penetration depth of soft x-rays are in the order of tens of nanometers [58], i.e., comparable to the full thickness of the thin-film. This, however, also means that the FY signal is largely affected by saturation and self-absorption effects and the spectral shape is consequently modified. We compared the FY results to fully strained and fully relaxed theoretical simulations in Fig. S13 of the supplementary information [28]. Although the tetragonal distortion $(D_s = 0.1 \text{ eV})$ shows better agreement with the experimental XMLD, it cannot reproduce all aspects of the spectra. This is likely due to the formation of multidomains composed of stressed and relaxed regions. It is difficult to quantify these domains from the current set of data because of the uncertainties imposed by the self-absorption and saturation effects. A systematic measurement of the XMLD angular dependence as a function of the film thickness could be used to quantify these domains and determine the experimental critical thickness at which these domains start to form in future experiments.

D. Origin of the symmetry selectivity

It is of theoretical and practical interest to understand the origin of the symmetry selectivity obtained for the measurements performed with the polarization aligned 30° from the [100] axis. This serves as a guide to design efficient experiments that can distinguish the local site symmetry and quantify the distortion parameters. A close inspection of the dependence of the XAS process on the polarization and the external magnetic field is therefore required. The general XAS cross-section can be expressed as in Eq. (1), where ϵ is the polarization vector, ω is the frequency of the light, α is the fine structure factor, **Im** is the imaginary part of the equation, and σ is the conductivity tensor [59] describing the materials properties [60]

$$XAS^{Dipole}(\boldsymbol{\epsilon}) = -4\pi\alpha\hbar\omega \mathbf{Im}[\boldsymbol{\epsilon}^* \cdot \boldsymbol{\sigma} \cdot \boldsymbol{\epsilon}]. \tag{1}$$

The conductivity tensor is a 3×3 matrix for a dipole transition as shown in Eq. (2). The matrix elements of the conductivity tensor are defined in Eq. (3), where ψ_i is the ground-state wave function, $T_{x(y)} = \epsilon_{x(y)} \cdot r_{x(y)}$ is the dipole transition operator, *H* is the Hamiltonian of the final state, and Γ is the lifetime broadening

$$\sigma = \begin{bmatrix} \sigma_{xx} & \sigma_{xy} & \sigma_{xz} \\ \sigma_{yx} & \sigma_{yy} & \sigma_{yz} \\ \sigma_{zx} & \sigma_{zy} & \sigma_{zz} \end{bmatrix},$$
(2)

$$\sigma_{xy} = \langle \psi_i | T_y^{\dagger} \frac{1}{\omega - H + i\Gamma/2} T_x | \psi_i \rangle.$$
(3)

In the most general case, nine independent measurements are required to fully reconstruct the conductivity tensor. However, the crystal symmetry can simplify the conductivity tensor by dictating equivalence between matrix elements or canceling out some of the matrix elements. The conductivity tensor of an octahedral Fe²⁺ ion with the magnetic field aligned parallel to the high symmetry [100] axis (i.e., the x axis with $\phi = 0^{\circ}$) is shown in Fig. 6(a). Here five of the nine matrix elements are finite (three diagonal elements: $\sigma_{xx}, \sigma_{yy}, \sigma_{zz}$, and two off-diagonal elements: σ_{yz} and σ_{zy}). The cubic crystal field implies that the x, y, and z directions are equivalent by symmetry, however, the magnetic field aligned to the x axis breaks the equivalency. For this reason, σ_{xx} is different from σ_{yy} and σ_{zz} . In addition, the x magnetic field induces off-diagonal terms σ_{yz} (σ_{zy}) leading to a scenario where an electric field in the z(y) direction can produce an excitation in the y(z) direction. Similarly, when the magnetic



FIG. 6. $L_{2,3}$ Fe²⁺ conductivity tensor (σ) for the three studied crystal systems namely; octahedral, tetragonal ($D_s = 0.1 \text{ eV}$), and trigonal ($D_{\sigma} = 0.1 \text{ eV}$). The simulations in the first row are for $\phi = 0^{\circ}$ (i.e., **B** || [100]) while the second row presents simulations done with $\phi = 90^{\circ}$ (i.e., **B** || [010]).

field is aligned along the [010] (y) axis (i.e., $\phi = 90^{\circ}$), σ_{yy} becomes inequivalent to σ_{xx} and σ_{zz} and it induces *x*-*z* off-diagonal terms [see Fig. 6(b)].

An analogous behavior is observed for tetragonal [Figs. 6(c) and 6(d)] and trigonal [Figs. 6(e) and 6(f)] calculations. Nonetheless, for the tetragonal case, the *z* axis is crystallographically inequivalent to the *x* and *y* axes. This is because the *z* direction is elongated with respect to the *x* and *y* ones due to the bi-axial in-plane compression. We recall that the trigonal calculation comprises of a summation over four sites such that the cubic symmetry is preserved. For this reason, the trigonal calculations behave fully like the octahedral.

Aligning the polarization parallel to the [100] direction results in spectra that are only sensitive to the σ_{xx} matrix element. A comparison of the imaginary part of σ_{xx} at $\phi = 0^{\circ}$ for the three symmetries is shown in Fig. 7. One concludes that the spectra are rather similar with the exception of the L_2 edge for the octahedral symmetry [Fig. 7(a)]. It is hence now clear why such a measurement is not optimum for the discrimination between the tetragonal and trigonal distortions. On the other hand, when the incident polarization is aligned 30° from the [100], it gains sensitivity to the σ_{xy} , σ_{yx} , and σ_{yy} terms. These components are nonzero and significantly different between the three crystal systems when the magnetic field is also aligned to a low symmetry direction as shown for the off-diagonal element σ_{xy} in Fig. 8. We therefore conclude that the reason for the symmetry selectivity achieved is due to the following.

(1) The presence of off-diagonal matrix elements that are significantly different for the three crystal systems. These off-diagonal elements are induced by aligning the magnetic field to a low symmetry orientation (with respect to the crystal field).



FIG. 7. The imaginary contribution of the Fe²⁺ $L_{2,3}$ diagonal matrix elements of the conductivity tensor (σ_{xx}) at $\phi = 0^{\circ}$ for octahedral (red), tetragonal ($D_s = 0.1 \text{ eV}$ in blue), and trigonal ($D_{\sigma} = -0.1 \text{ eV}$ in green) distortion.



FIG. 8. The imaginary contribution of the $L_{2,3}$ Fe²⁺ off-diagonal element σ_{xy} at $\phi = 30^{\circ}$ for octahedral (red), tetragonal ($D_s = 0.1$ eV in blue), and trigonal ($D_{\sigma} = 0.1$ eV in green) distortions.

(2) Aligning the polarization such that it becomes sensitive to these inequivalent elements.

IV. CONCLUSION

We observed strong XMLD in a Fe_3O_4 38-nm thin-film grown on 0.1% Nb-doped on a SrTiO₃ (001) TiO₂-terminated

- J. van den Brink and D. I. Khomskii, J. Phys. Condens. Matter 20, 434217 (2008).
- [2] J.-B. Moussy, J. Phys. D Appl. Phys. 46, 143001 (2013).
- [3] J. Ngai, F. Walker, and C. Ahn, Annu. Rev. of Mater. Res. 44, 1 (2014).
- [4] S. Dong, J.-M. Liu, S.-W. Cheong, and Z. Ren, Adv. Phys. 64, 519 (2015).
- [5] M. Huijben, G. Koster, Z. L. Liao, and G. Rijnders, Appl. Phys. Rev. 4, 041103 (2017).
- [6] A. Yanase and K. Siratori, J. Phys. Soc. Jpn 53, 312 (1984).
- [7] Z. Zhang and S. Satpathy, Phys. Rev. B 44, 13319 (1991).
- [8] V. N. Antonov, B. N. Harmon, and A. N. Yaresko, Phys. Rev. B 67, 024417 (2003).
- [9] E. J. W. Verwey, Nature 144, 327 (1939).
- [10] E. J. W. Verwey and P. W. Haayman, Physica 8, 979 (1941).
- [11] F. Walz, J. Phys. Condens. Matter 14, R285 (2002).
- [12] J. García and G. Subías, J. Phys. Condens. Matter 16, R145 (2004).
- [13] M. S. Senn, J. P. Wright, and J. P. Attfield, Nature 481, 173 (2012).
- [14] M. S. Senn, J. P. Wright, and J. P. Attfield, J. Korean Phys. Soc. 62, 1372 (2013).
- [15] N. Pontius, T. Kachel, C. Schüßler-Langeheine, W. F. Schlotter, M. Beye, F. Sorgenfrei, C. F. Chang, A. Föhlisch, W. Wurth, P. Metcalf, I. Leonov, A. Yaresko, N. Stojanovic, M. Berglund, N. Guerassimova, S. Düsterer, H. Redlin, and H. A. Dürr, Appl. Phys. Lett. 98, 182504 (2011).
- [16] S. de Jong, R. Kukreja, C. Trabant, N. Pontius, C. F. Chang, T. Kachel, M. Beye, F. Sorgenfrei, C. H. Back, B. Bräuer, W. F. Schlotter, J. J. Turner, O. Krupin, M. Doehler, D. Zhu, M. A. Hossain, A. O. Scherz, D. Fausti, F. Novelli, M. Esposito,

substrate. Based on the a high symmetry XMLD experimental geometry, it was concluded that the local symmetry of the Fe B sites of Fe_3O_4 are not perfectly octahedral. However, it was not possible to determine unambiguously the nature of the distortion. We demonstrated that it is possible to pinpoint the local symmetry of the Fe^{2+} ions in Fe_3O_4 by a systematic analysis of the XMLD signal in an optimized geometry. We found that the local symmetry of the Fe^{2+} B sites is trigonal with a distortion parameter $D_{\sigma} = 0.1 \text{ eV}$ which is very close to that of bulk Fe₃O₄ [61]. This implies that the top \sim 5-nm thin-films are fully relaxed at this thickness. We provided a detailed analysis of the XMLD signal and a guide to optimize the symmetry selectivity of an XMLD experiment. The methodology developed here has far-reaching implications especially for the investigation of the electronic structure of strain-engineered oxide thin-films and heterostructures.

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W. S. Lee, Y. D. Chuang, D. H. Lu, R. G. Moore, M. Yi, M. Trigo, P. Kirchmann, L. Pathey, M. S. Golden, M. Buchholz, P. Metcalf, F. Parmigiani, W. Wurth, A. Föhlisch, C. Schüßler-Langeheine, and H. A. Dürr, Nat. Mater 12, 882 (2013).

- [17] C. Haavik, S. Stølen, H. Fjellvaåg, M. Hanfland, and D. Häusermann, Am. Mineral. 85, 514 (2000).
- [18] M. Monti, M. Sanz, M. Oujja, E. Rebollar, M. Castillejo, F. J. Pedrosa, A. Bollero, J. Camarero, J. L. F. Cuñado, N. M. Nemes, F. J. Mompean, M. Garcia-Hernández, S. Nie, K. F. McCarty, A. T. N'Diaye, G. Chen, A. K. Schmid, J. F. Marco, and J. de la Figuera, J. Appl. Phys **114**, 223902 (2013).
- [19] M. H. Hamed, R. A. Hinz, P. Lömker, M. Wilhelm, A. Gloskovskii, P. Bencok, C. Schmitz-Antoniak, H. Elnaggar, C. M. Schneider, and M. Müller, ACS Appl. Mater. Interfaces 11, 7576 (2019).
- [20] X. H. Liu, A. D. Rata, C. F. Chang, A. C. Komarek, and L. H. Tjeng, Phys. Rev. B 90, 125142 (2014).
- [21] S. Kale, S. M. Bhagat, S. E. Lofland, T. Scabarozi, S. B. Ogale, A. Orozco, S. R. Shinde, T. Venkatesan, B. Hannoyer, B. Mercey, and W. Prellier, Phys. Rev. B 64, 205413 (2001).
- [22] M. Luysberg, R. G. S. Sofin, S. K. Arora, and I. V. Shvets, Phys. Rev. B 80, 024111 (2009).
- [23] A. Hamie, Y. Dumont, E. Popova, A. Fouchet, B. Warot-Fonrose, C. Gatel, E. Chikoidze, J. Scola, B. Berini, and N. Keller, Thin Solid Films 525, 115 (2012).
- [24] C. Kim, I. K. Robinson, J. Myoung, K. Shim, M. Yoo, and K. Kim, Appl. Phys. Lett. 69, 2358 (1996).
- [25] C. F. Chang, Z. Hu, S. Klein, X. H. Liu, R. Sutarto, A. Tanaka, J. C. Cezar, N. B. Brookes, H.-J. Lin, H. H. Hsieh, C. T. Chen, A. D. Rata, and L. H. Tjeng, Phys. Rev. X 6, 041011 (2016).

- [26] X. Liu, C.-F. Chang, A. D. Rata, A. C. Komarek, and L. H. Tjeng, Npj Quantum Materials 1, 16027 (2016).
- [27] T. Yamanaka, N. Hirai, and Y. Komatsu, Am. Mineral. 87, 1183 (2002).
- [28] See Supplemental Material at http://link.aps.org/supplemental/ 10.1103/PhysRevMaterials.4.024415 for more information on these figures.
- [29] M. W. Haverkort, M. Zwierzycki, and O. K. Andersen, Phys. Rev. B 85, 165113 (2012).
- [30] Y. Lu, M. Höppner, O. Gunnarsson, and M. W. Haverkort, Phys. Rev. B 90, 085102 (2014).
- [31] M. W. Haverkort, G. Sangiovanni, P. Hansmann, A. Toschi, Y. Lu, and S. Macke, Europhys. Lett. 108, 57004 (2014).
- [32] F. de Groot and A. Kotani, *Core Level Spectroscopy of Solids*, 1st ed., (CRC Press, Boca Raton, FL, 2008).
- [33] T. Funk, A. Deb, S. J. George, H. Wang, and S. P. Cramer, Coord. Chem. Rev. 249, 3 (2005).
- [34] F. de Groot, Coord. Chem. Rev. 249, 31 (2005).
- [35] P. Carra, B. T. Thole, M. Altarelli, and X. Wang, Phys. Rev. Lett. 70, 694 (1993).
- [36] F. de Groot, J. Electron Spectrosc. Relat. Phenom. 67, 529 (1994).
- [37] M. M. van Schooneveld, R. W. Gosselink, T. M. Eggenhuisen, M. Al Samarai, C. Monney, K. J. Zhou, T. Schmitt, and F. M. F. de Groot, Angew. **52**, 1170 (2013).
- [38] P. Kuiper, B. Searle, L.-C. Duda, R. Wolf, and P. van der Zaag, J. Electron Spectros. Relat. Phenomena. 86, 107 (1997).
- [39] E. Goering, S. Gold, M. Lafkioti, and G. Schütz, Europhys. Lett. 73, 97 (2006).
- [40] E. Goering, M. Lafkioti, S. Gold, and G. Schütz, J. Magn. Magn. Mater. **310**, e249 (2007).
- [41] C. Carvallo, P. Sainctavit, M. A. Arrio, N. Menguy, Y. Wang, G. Ona-Nguema, and S. Brice-Profeta, Am. Mineral. 93, 880 (2008).
- [42] H. Elnaggar, R.-P. Wang, S. Lafuerza, E. Paris, Y. Tseng, D. McNally, A. C. Komarek, H. Guo, M. Haverkort, T. Schmitt, and F. M. F. de Groot, ACS Appl. Mater. Interfaces 11, 36213 (2019).
- [43] R. A. D. Pattrick, G. van der Laan, C. M. B. Henderson, P. Kuiper, E. Dudzik, and D. J. Vaughan, Eur. J. Mineral. 14, 1095 (2002).
- [44] P. Kuiper, B. G. Searle, P. Rudolf, L. H. Tjeng, and C. T. Chen, Phys. Rev. Lett. 70, 1549 (1993).

- [45] D. Alders, L. H. Tjeng, F. C. Voogt, T. Hibma, G. A. Sawatzky, C. T. Chen, J. Vogel, M. Sacchi, and S. Iacobucci, Phys. Rev. B 57, 11623 (1998).
- [46] A. Scholl, J. Stöhr, J. Lüning, J. W. Seo, J. Fompeyrine, H. Siegwart, J.-P. Locquet, F. Nolting, S. Anders, E. E. Fullerton, M. R. Scheinfein, and H. A. Padmore, Science 287, 1014 (2000).
- [47] F. U. Hillebrecht, H. Ohldag, N. B. Weber, C. Bethke, U. Mick, M. Weiss, and J. Bahrdt, Phys. Rev. Lett. 86, 3419 (2001).
- [48] J. Lüning, F. Nolting, A. Scholl, H. Ohldag, J. W. Seo, J. Fompeyrine, J.-P. Locquet, and J. Stöhr, Phys. Rev. B 67, 214433 (2003).
- [49] M. W. Haverkort, S. I. Csiszar, Z. Hu, S. Altieri, A. Tanaka, H. H. Hsieh, H.-J. Lin, C. T. Chen, T. Hibma, and L. H. Tjeng, Phys. Rev. B 69, 020408(R) (2004).
- [50] E. Arenholz, G. van der Laan, R. V. Chopdekar, and Y. Suzuki, Phys. Rev. B 74, 094407 (2006).
- [51] M. Finazzi, A. Brambilla, P. Biagioni, J. Graf, G.-H. Gweon, A. Scholl, A. Lanzara, and L. Duò, Phys. Rev. Lett. 97, 097202 (2006).
- [52] C. Luo, H. Ryll, C. H. Back, and F. Radu, Sci. Rep. 9, 18169 (2019).
- [53] G. van der Laan and B. T. Thole, Phys. Rev. B 43, 13401 (1991).
- [54] G. van der Laan, Phys. Rev. B 57, 5250 (1998).
- [55] S. S. Dhesi, G. van der Laan, E. Dudzik, and A. B. Shick, Phys. Rev. Lett. 87, 067201 (2001).
- [56] G. van der Laan, N. D. Telling, A. Potenza, S. S. Dhesi, and E. Arenholz, Phys. Rev. B 83, 064409 (2011).
- [57] S. Gota, M. Gautier-Soyer, and M. Sacchi, Phys. Rev. B 62, 4187 (2000).
- [58] C. T. Chen, Y. U. Idzerda, H.-J. Lin, N. V. Smith, G. Meigs, E. Chaban, G. H. Ho, E. Pellegrin, and F. Sette, Phys. Rev. Lett. 75, 152 (1995).
- [59] σ is also referred to as the fundamental spectra as in Refs. [62,63].
- [60] M. W. Haverkort, N. Hollmann, I. P. Krug, and A. Tanaka, Phys. Rev. B 82, 094403 (2010).
- [61] H. Elnaggar, P. Sainctavit, A. Juhin, S. Lafuerza, F. Wilhelm, A. Rogalev, M.-A. Arrio, C. Brouder, M. van der Linden, Z. Kakol, M. Sikora, M. W. Haverkort, P. Glatzel, and F. M. F. de Groot, Phys. Rev. Lett. **123**, 207201 (2019).
- [62] C. Brouder, J. Condens. Matter Phys. 2, 701 (1990).
- [63] C. Brouder, A. Juhin, A. Bordage, and M.-A. Arrio, J. Condens. Matter. Phys 20, 455205 (2008).